Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/623,576	CHEN ET AL.
Examiner	Art Unit
Joseph Haley	2627

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	d interference arch	5/31/2007	JRH	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
see updated EAST search notes	5/31/2007	JRH	